

**Notice of References Cited**

Application/Control No.

10/773,610

Applicant(s)/Patent Under  
Reexamination  
YAMANAKA ET AL.

Examiner

Emmanuel Bayard

Art Unit

2611

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,187,730	03-2007	Hu et al.	375/343
*	C	US-6,088,390	07-2000	Russell et al.	375/233
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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